

LIST OF PUBLICATIONS
CITED BY APPLICANT

Attv. Docket No.
SEL 213

Serial No.
09/685,698

Applicant
Shunpei YAMAZAKI
et al

Filing Date
October 10, 2000

Group
2813

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
LH LH	5,189,405	02/23/93	Yamashita et al	340	781	12/23/91
	5,920,080	07/06/99	Jones	257	40	05/08/98

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	DOCUMENT NUMBER	DATE	APPLICANT	English Abstract	English Trans.	FILING DATE

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(Include name of author (in CAPITAL LETTERS), title of article or item (book, magazine, journal, serial, symposium, catalog, etc.) date, pages(s), volume-issue number(s), publisher, city and/or country where published).

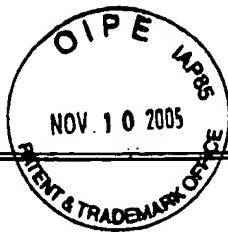
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hanna Schulz

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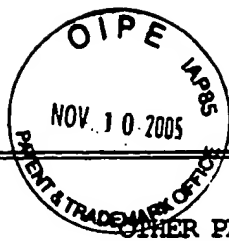
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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
Lu	3,484,793	12/16/69	Weigl	347	2	05/02/66
	3,878,517	04/15/75	Kasubuchi et al	346	75	06/01/73
	4,281,332	07/28/81	Horiike	346	75	12/26/79
	4,788,629	11/29/88	Handy et al	362	23	10/29/86
	4,882,518	11/21/89	Cherry	313	512	05/25/88
	4,951,064	08/21/90	Kun et al	346	107	05/15/89
	4,994,540	02/19/91	Boerner et al	528	44	01/16/90
	4,999,229	03/12/91	Moritani et al	428	36.6	12/29/88
	5,059,148	10/22/91	McKenna et al	445	25	12/21/87
	5,278,223	01/11/94	Gruenewaelder et al	524	502	03/27/92
	5,304,419	04/19/94	Shores	428	355	03/09/92
	5,334,539	08/02/94	Shinar et al	437	1	01/29/93
	5,643,826	07/01/97	Ohtani et al	437	88	10/25/94
	5,663,573	09/02/97	Epstein et al	257	40	03/17/95
	5,684,365	11/04/97	Tang et al	315	169.3	12/14/94
	5,747,930	05/05/98	Utsugi	313	504	05/17/95
	5,770,892	06/23/98	Chan et al	257	903	06/02/95
	5,821,003	10/13/98	Uemura et al	428	690	09/20/96
	5,839,456	11/24/98	Han	134	104.1	08/20/97
	5,882,761	03/16/99	Kawami et al	428	69	11/19/96
	5,923,962	07/13/99	Ohtani et al	438	150	04/28/95
	5,928,794	07/27/99	Kalinowski et al	428	447	12/03/97
	5,962,962	10/05/99	Fujita et al	313	412	03/05/97
	5,972,419	10/26/99	Roitman	427	66	06/13/97
	6,057,647	05/02/00	Kurosawa et al	315	169.3	12/22/98
	6,087,771	07/11/00	Roitman	313	503	08/31/99
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	6,251,712 B1	06/26/01	Tanaka et al	438	143	09/12/97
	US 2002/ 0075422 A1	06/20/02	Kimura et al	349	43	07/10/01
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<i>Lu</i> 	JP 62-090260	04/24/87	TDK Corp.	X		10/16/85
	EP 0 347 058	12/20/89	Nordson Corp.			05/26/89
	JP 07-130652	05/19/95	Semiconductor	X		10/29/93
			Energy Lab Co Ltd.			
	JP 08-078159	03/22/96	Idemitsu Kosan Co.	X		09/08/94
	EP 0 717 446	06/19/96	Eastman Kodak Co.			12/05/95
	JP 08-234683	09/13/96	Eastman Kodak Co.	X		12/12/95
	JP 08-330602	12/13/96	Semiconductor	X		03/27/96
			Energy Lab Co Ltd.			
	EP 0 776 147	05/28/97	Pioneer Electronic Corp.			11/20/96
	JP 09-148066	06/06/97	Pioneer Electronic Corp.	X		11/24/95
			Idemitsu Kosan Co.			09/05/95
	EP 0 781 075	06/25/97	Idemitsu Kosan Co.			01/25/96
	JP 09-194831	07/29/97	NEC Corp.	X		12/24/97
	JP 10-189525	07/21/98	LG Semicon Co Ltd.	X		09/18/97
	EP 0 862 156	09/02/98	Seiko Epson Corp.			03/27/97
	JP 10-270363	10/09/98	Semiconductor	X		
			Energy Lab Co Ltd.			
	EP 0 883 191	12/09/98	Canon Kabushiki Kaisha			05/29/98
			Hewlett Packard Co	X		06/08/98
	JP 11-016679	01/22/99	Seiko Epson Corp.	X		07/31/97
	JP 11-054272	02/26/99	Seiko Epson Corp.			08/18/98
	WO 99/10861	03/04/99	Stella Chemifa			12/15/97
	EP 0 903 778	03/24/99	Kabushiki Kaisha			08/18/98
	A1		Seiko Epson Corp.			
	EP 0 940 796	09/08/99	Semiconductor	X		03/15/00
	JP 2000-340798	12/08/00	Energy Lab Co Ltd.			
	EP 1 093 166	04/18/01	Semiconductor			10/12/00
			Energy Lab Co Ltd.			



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Lu
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Lu

- 1) WU, C.C. et al, "Integration of Organic LED's and Amorphous Si TFT's Onto Unbreakable Metal Foil Substrates," International Electron Devices Meeting, San Francisco, CA, December 8-11, 1996, IDEM 1996 Technical Digest, pp. 957-959, (1996).
- 2) SHIM, H. et al, "Electrical and Optical Polymer Systems," Donald L. Wise, ed., p. 938, (1998).
- 3) HART, J.A. et al, "A History of Electroluminescent Displays," <http://www.indiana.edu/~hightech/fpd/papers/ELDs.html> pp. 1-18 (1999).
- 4) European Search Report re application no. EP 00122446.8, dated June 26, 2001.
- 5) EPO Office Action re application no. EP 00122446.8, dated November 4, 2003.
- 6) European Search Report re application no. EP 00113577.1, dated March 1, 2004.
- 7) European search report re application no. EP 01102402.3, dated April 25, 2005.

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Walter Schlegel

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	5,757,396	05/26/98	Bruner	347	27	06/30/94
	US 2001/ 0023661 A1	09/27/01	Hiroki et al	118	300	02/02/01
	US 2003/ 0003231 A1	01/02/03	Kiguchi et al	427	282	01/19/99
	US 2003/ 0196597 A1	10/23/03	Yamazaki et al	118	300	04/22/03
	US 2004/ 0048001 A1	03/11/04	Kiguchi et al	427	421	05/27/03
	6,797,980 B2	09/28/04	Takiguchi et al	257	40	11/29/01
	6,830,494 B1	12/14/04	Yamazaki et al	445	24	10/06/00
	US 2005/ 0012445 A1	01/20/05	Yamazaki et al	315	500	07/30/04
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	JP 10-060331	03/03/98	Kao Corp.	X		08/13/96
	EP 0 930 641	07/21/99	Seiko Epson Corp.			01/19/98
	JP 11-268296	10/05/99	Toshiba Corp.	X		03/26/98
	DE 19918193	11/25/99	Cambridge Display Technology Ltd.	X		04/22/90

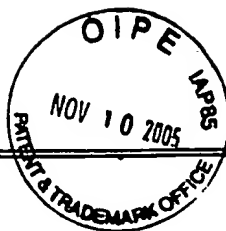
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Jh ↓ Rr	6,373,453 B1	04/16/02	Yudasaka	345	76	04/20/99
	6,585,910 B1	07/01/03	Kikuyama et al	252	79.3	03/36/99
	6,776,844 B2	08/17/04	Yonekura et al	118	621	03/26/02

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